

Notes:

- 1. All dimensions are in millimeters.
- 2. Tolerance is \pm 0.1mm (.004") unless otherwise noted.

Features

- * Top view, wide view angle, single color Chip LED.
- * Package in 8mm tape on 7" diameter reels.
- * Compatible with automatic Pick & Place equipment.
- * Compatible with Infrared and Wave soldering reflow solder processes.
- * EIA STD package.
- * I.C. compatible.

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REV:A/Ø

• Chip Materials

- * Dice Material : AlInGaP
- * Light Color : Super Red
- * Lens Color : Water Clear

• Absolute Maximum Ratings(Ta=25)

Symbol	Parameter	Rating	Unit
PD	Power Dissipation	75	mW
Inc	Peak Forward Current	80	mA
Ipf	(1/10 Duty Cycle, 0.1ms Pulse Width)	80	
IF	Continuous Forward Current	30	mA
-	De-rating Linear From 25	0.25	mA/
VR	Reverse Voltage	5	V
ESD	Electrostatic Discharge Threshold(HBM) ^{Note A}	2000	V
Topr	Operating Temperature Range	-40 ~ +85	
Tstg	Storage Temperature Range	-40 ~ +85	
-	Wave Soldering Condition (Two times Max.)	260 (for 5 seconds)	
-	Infrared Soldering Condition (Two times MAX.)	240 (for 5 seconds)	

Note A :

HBM : Human Body Model. Seller gives no other assurances regarding the ability of to withstand ESD.

• Electro-Optical Characteristics(Ta=25)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Test Condition
Luminous Intensity	IV	16.0	40.0	80.0	mcd	IF=20mA
Viewing Angle	2 1/2		130		deg	Note 2
Peak Emission Wavelength	р		639		nm	Measurement @Peak
Dominant Wavelength	d		631		nm	IF=20mA
Spectral Line Half-Width			17		nm	
Forward Voltage	VF		2.0	2.4	V	IF =20mA
Reverse Current	IR			100	μA	VR = 5V

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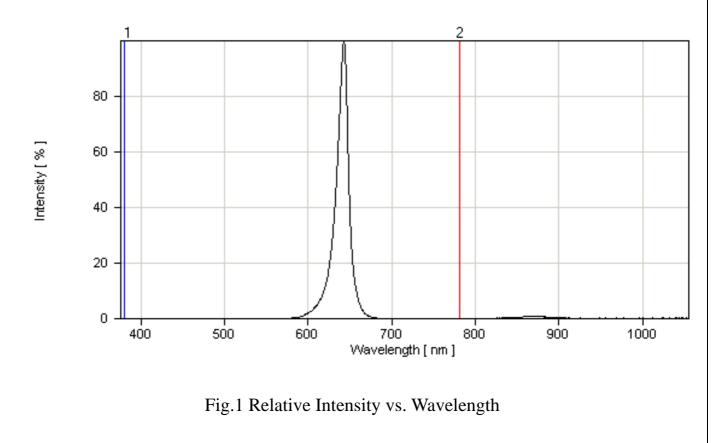
Notes:

- 1. Luminous intensity is measured with a light sensor and filter combination that proximities the CIE eye-response curve.
- 2. 1/2 is the off-axis angle at which the luminous intensity is half the axial luminous intensity.
- 3. The dominant wavelength d is derived from the CIE chromaticity diagram and represents the single wavelength which defines the color of the device.
- 4. Caution in ESD :

Static Electricity and surge damages the LED. It is recommend use a wrist band or anti-electrostatic glove when handling the LED. All devices, equipment and machinery must be properly grounded.

5. Major standard testing equipment by "Instrument System" Model : CAS140B Compact Array Spectrometer and "KEITHLEY" Source Meter Model : 2400.

Typical Electro-Optical Characteristics Curves





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Typical Electro-Optical Characteristics Curves

(25 Ambient Temperature Unless Otherwise Noted)

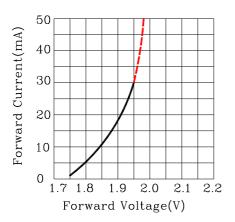


Fig.2 Forward Current vs.Forward Voltage

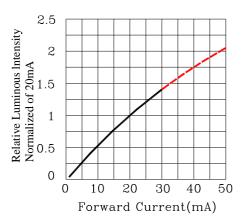
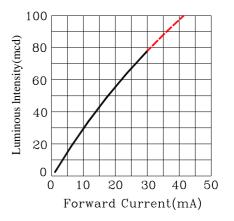
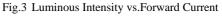


Fig.4 Relative Luminous Intensity vs.Forward Current





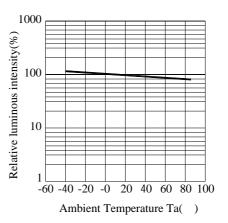
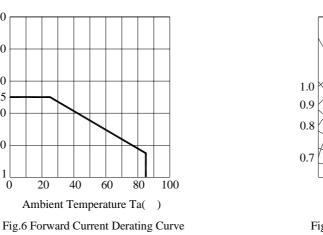
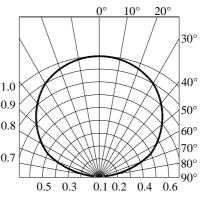


Fig.5 Luminous Intensity VS Ambient Temperature







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50

40

30

25

20

10

1

0

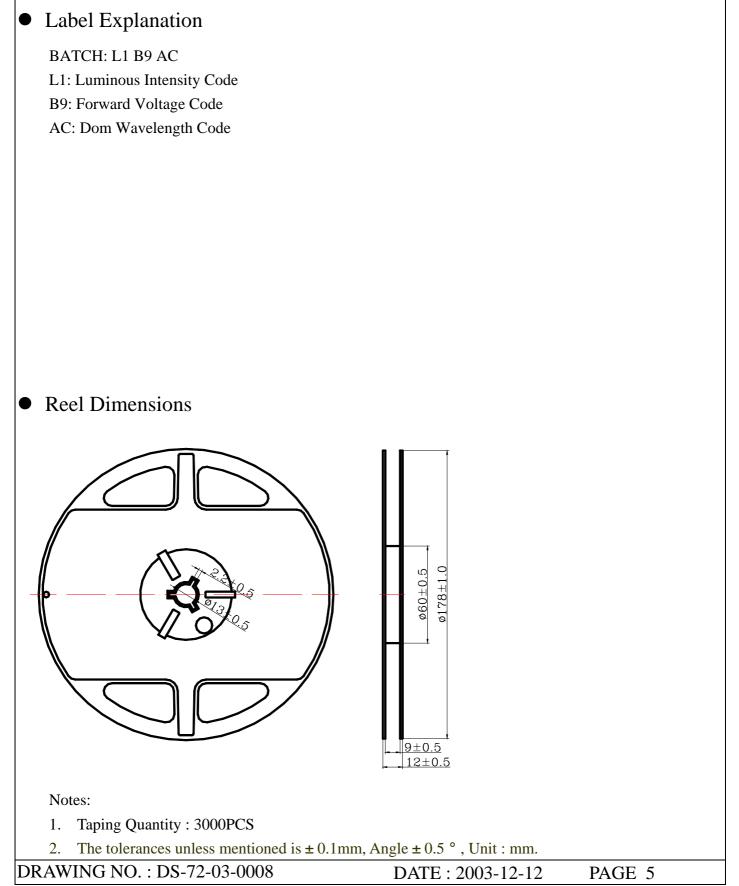
20

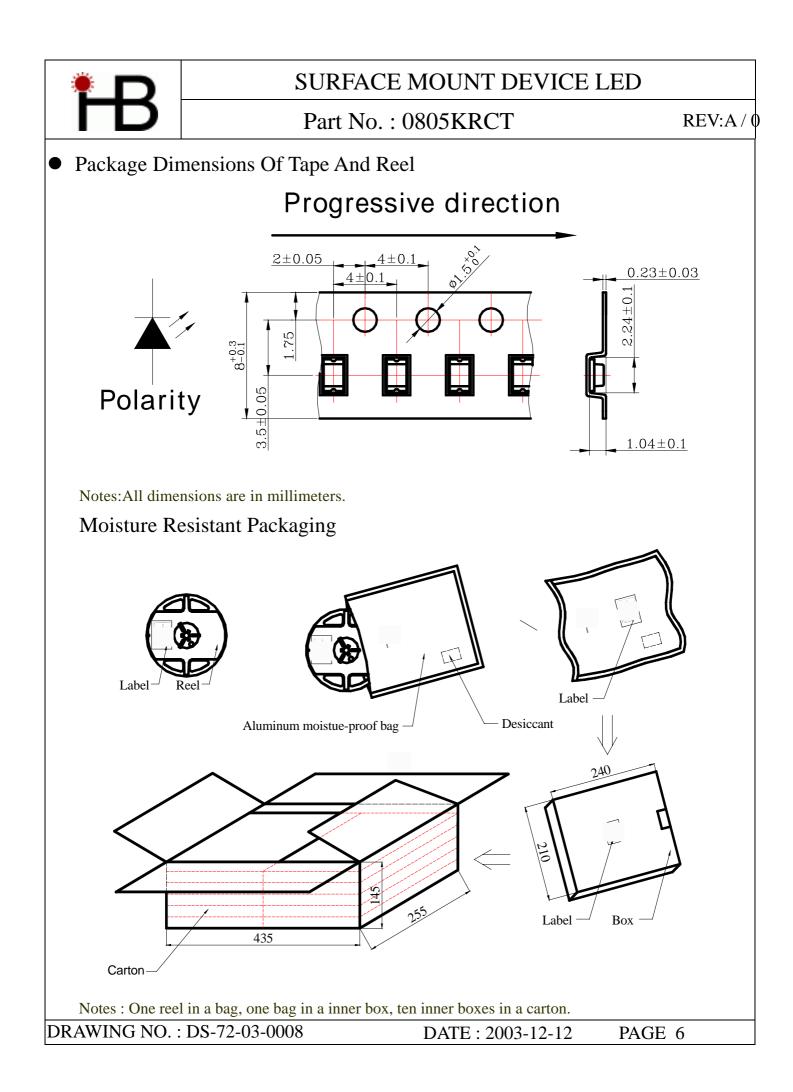
Forward Current IF(mA)



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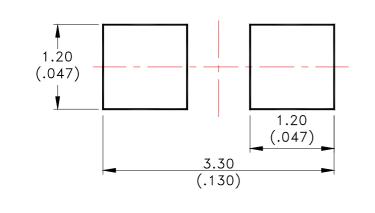
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• Cleaning

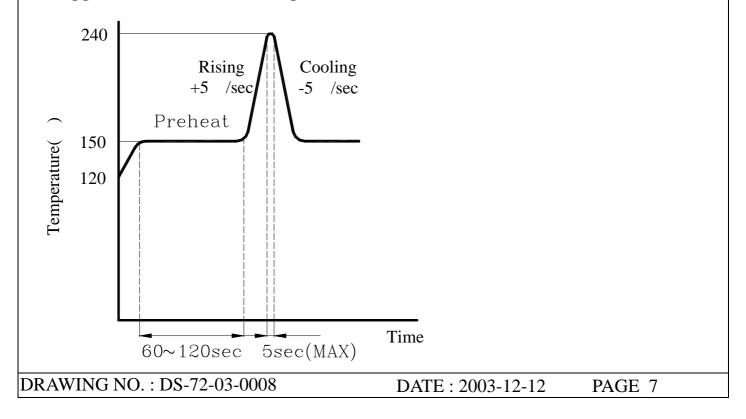
- * If cleaning is required, use the following solutions for less than 1 minute and less than 40
- * Appropriate chemicals: Ethyl alcohol and isopropyl alcohol.
- Effect of ultrasonic cleaning on the LED resin body differs depending on such factors as the oscillator output, size of PCB and LED mounting method. The use of ultrasonic cleaning should be enforced at proper output after confirming there is no problem.

Suggest Soldering Pad Dimensions



Direction of PWB camber and go to reflow furnace

• Suggest IR Reflow Soldering Profile Condition:





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• Bin Code List

Luminous Intensity(IV), Unit:mcd@20mA					
Bin Code	Min	Max			
М	16.0	32.0			
Ν	25.0	50.0			
Р	40.0	80.0			

Including test tolerance

• CAUTIONS

1. Application Limitation :

The LED's described here are intended to be used for ordinary electronic equipment (such as office equipment, communication equipment and household application).Consult HB's sales in advance for information on application in which exceptional quality and reliability are required, particularly when the failure or malfunction of the LED's may directly jeopardize life or health (such as airplanes, automobiles, traffic control equipment, life support system and safety devices).

2.Storage :

Before opening the package :

The LEDs should be kept at 30°C or less and 85%RH or less. The LEDs should be used within a year.

After opening the package :

The LEDs should be kept at 30°C or less and 70%RH or less. The LEDs should be soldered within 168 hours(7 days) after opening the package.

Please avoid rapid transitions in ambient temperature in high humidity environments where condensation may occur.

3.Soldering

Do not apply any stress to the lead frame during soldering while the LED is at high temperature. Recommended soldering condition.

Reflow Soldering :

Pre-heat 120~150°C, 120sec. MAX., Peak temperature : 240°C Max. Soldering time : 10 sec Max. Soldering Iron : (Not recommended)

Temperature 300°C Max., Soldering time : 3 sec. Max.(one time only), power dissipation of iron :

20W Max. use SN60 solder of solder with silver content and don't to touch LED lens when soldering. Wave soldering :

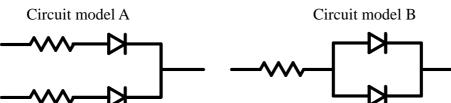
Pre-heat 100°C Max, Pre-heat time 60 sec. Max, Solder wave 260°C Max, Soldering time 5 sec. Max. preformed consecutively cooling process is required between 1^{st} and 2^{nd} soldering processes.

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4. Drive Method



(A)Recommended circuit.

(B)The difference of brightness between LED's could be found due to the Vf-If characteristics of LED.

5.Reliability Test

Classification	Test Item	Test Condition	Reference Standard
Endurance Test	Operation Life	Ta= Under Room Temperature As Per Data Sheet Maximum Rating *Test Time= 1000HRS (-24HRS,+72HRS)*@20mA.	MIL-STD-750D:1026 (1995) MIL-STD-883D:1005 (1991) JIS C 7021:B-1 (1982)
	High Temperature High Humidity Storage	IR-Reflow In-Board, 2 Times Ta= 65±5 ,RH= 90 ~ 95% *Test Time= 1000HRS±2HRS	MIL-STD-202F:103B(1980) JIS C 7021:B-11(1982)
	High Temperature Storage	Ta= 105±5 Test Time= 1000HRS (-24HRS,72HRS)	MIL-STD-883D:1008 (1991) JIS C 7021:B-10 (1982)
	Low Temperature Storage	Ta= -55±5 *Test Time=1000HRS (-24HRS,72H RS)	JIS C 7021:B-12 (1982)
Environmental Test	Temperature Cycling	105±5 -55±5 10mins 10mins 100 Cycles	MIL-STD-202F:107D (1980) MIL-STD-750D:1051(1995) MIL-STD-883D:1010 (1991) JIS C 7021:A-4(1982)
	Thermal Shock	IR-Reflow In-Board, 2 Times105±5-5510mins10mins100 Cycles	MIL-STD-202F:107D(1980) MIL-STD-750D:1051(1995) MIL-STD-883D:1011 (1991)
	Solder Resistance	Tsol= 260 ± 5 Dwell Time= 10 ± 1 sec	MIL-STD-202F:210A(1980) MIL-STD-750D:2031(1995) JIS C 7021:A-1(1982)
	Solder ability	Tsol= 235 ± 5 Immersion time 2 ± 0.5 sec Immersion rate 25 ± 2.5 mm/sec Coverage 95% of the dipped surface	MIL-STD-202F:208D(1980) MIL-STD-750D:2026(1995) MIL-STD-883D:2003(1991) IEC 68 Part 2-20 JIS C 7021:A-2(1982)

6.Others:

The appearance and specifications of the product may be modified for improvement without notice.

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